

## 54ABT245

### Octal Bidirectional Transceiver with TRI-STATE® Outputs

#### General Description

The 54ABT245 contains eight non-inverting bidirectional buffers with TRI-STATE outputs and is intended for bus-oriented applications. Current sinking capability is 48 mA on both the A and B ports. The Transmit/Receive (T/R) input determines the direction of data flow through the bidirectional transceiver. Transmit (active HIGH) enables data from A ports to B ports; Receive (active LOW) enables data from B ports to A ports. The Output Enable input, when HIGH, disables both A and B ports by placing them in a High Z condition.

#### Features

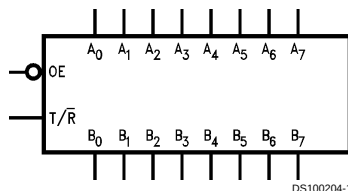
- Bidirectional non-inverting buffers
- A and B output sink capability of 48 mA, source capability of 24 mA

- Guaranteed output skew
- Guaranteed multiple output switching specifications
- Output switching specified for both 50 pF and 250 pF loads
- Guaranteed simultaneous switching, noise level and dynamic threshold performance
- Guaranteed latchup protection
- High impedance glitch-free bus loading during entire power up and power down cycle
- Non-destructive hot insertion capability
- Disable time is less than enable time to avoid bus contention
- Standard Microcircuit Drawing (SMD) 5962-9214801

#### Ordering Code:

| Military      | Package Number | Package Description                           |
|---------------|----------------|-----------------------------------------------|
| 54ABT245J-QML | J20A           | 20-Lead Ceramic Dual-In-Line                  |
| 54ABT245W-QML | W20A           | 20-Lead Cerpak                                |
| 54ABT245E-QML | E20A           | 20-Lead Ceramic Leadless Chip Carrier, Type C |

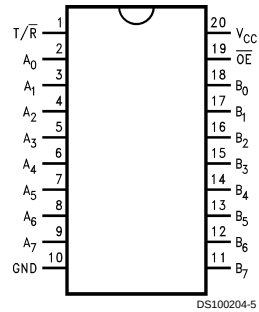
#### Logic Symbol



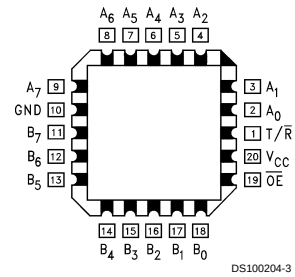
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## Connection Diagrams

Pin Assignment for DIP and Flatpak.



Pin Assignment for LCC



## Pin Descriptions

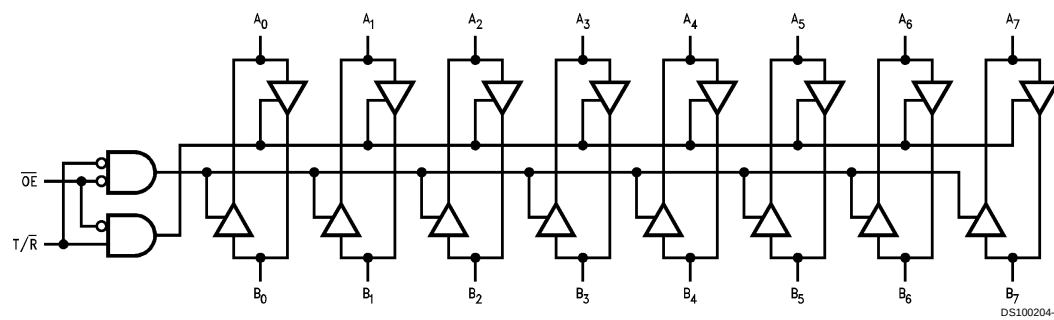
| Pin Names        | Description                        |
|------------------|------------------------------------|
| $\overline{OE}$  | Output Enable Input (Active LOW)   |
| $T/\overline{R}$ | Transmit/Receive Input             |
| $A_0-A_7$        | Side A Inputs or TRI-STATE Outputs |
| $B_0-B_7$        | Side B Inputs or TRI-STATE Outputs |

## Truth Table

| Inputs          |                  | Output              |
|-----------------|------------------|---------------------|
| $\overline{OE}$ | $T/\overline{R}$ |                     |
| L               | L                | Bus B Data to Bus A |
| L               | H                | Bus A Data to Bus B |
| H               | X                | High Z State        |

H = HIGH Voltage Level  
L = LOW Voltage Level  
X = Immaterial

## Logic Diagram



## Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

|                                                                  |                          |
|------------------------------------------------------------------|--------------------------|
| Storage Temperature                                              | –65°C to +150°C          |
| Ambient Temperature under Bias                                   | –55°C to +125°C          |
| Junction Temperature under Bias                                  |                          |
| Ceramic                                                          | –55°C to +175°C          |
| V <sub>CC</sub> Pin Potential to Ground Pin                      | –0.5V to +7.0V           |
| Input Voltage (Note 2)                                           | –0.5V to +7.0V           |
| Input Current (Note 2)                                           | –30 mA to +5.0 mA        |
| Voltage Applied to Any Output in the Disabled or Power-off State | –0.5V to 5.5V            |
| in the HIGH State                                                | –0.5V to V <sub>CC</sub> |
| Current Applied to Output                                        |                          |

|                            |                                      |
|----------------------------|--------------------------------------|
| in LOW State (Max)         | twice the rated I <sub>OL</sub> (mA) |
| DC Latchup Source Current  | –500 mA                              |
| Over Voltage Latchup (I/O) | 10V                                  |

## Recommended Operating Conditions

|                              |                 |
|------------------------------|-----------------|
| Free Air Ambient Temperature | –55°C to +125°C |
| Military Supply Voltage      |                 |
| Military                     | +4.5V to +5.5V  |
| Minimum Input Edge Rate      | (ΔV/Δt)         |
| Data Input                   | 50 mV/ns        |
| Enable Input                 | 20 mV/ns        |

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

**Note 2:** Either voltage limit or current limit is sufficient to protect inputs.

## DC Electrical Characteristics

| Symbol                             | Parameter                               |                   | ABT245   |      | Units | V <sub>CC</sub> | Conditions                                                                                                                                           |
|------------------------------------|-----------------------------------------|-------------------|----------|------|-------|-----------------|------------------------------------------------------------------------------------------------------------------------------------------------------|
|                                    |                                         |                   | Min      | Typ  |       |                 |                                                                                                                                                      |
| V <sub>IH</sub>                    | Input HIGH Voltage                      |                   | 2.0      |      | V     |                 | Recognized HIGH Signal                                                                                                                               |
| V <sub>IL</sub>                    | Input LOW Voltage                       |                   | 0.8      |      | V     |                 | Recognized LOW Signal                                                                                                                                |
| V <sub>CD</sub>                    | Input Clamp Diode Voltage               |                   | –1.2     |      | V     | Min             | I <sub>IN</sub> = –18 mA ( $\overline{OE}$ , T/ $\overline{R}$ )                                                                                     |
| V <sub>OH</sub>                    | Output HIGH Voltage                     | 54ABT             | 2.5      |      | V     | Min             | I <sub>OH</sub> = –3 mA (A <sub>n</sub> , B <sub>n</sub> )                                                                                           |
|                                    |                                         | 54ABT             | 2.0      |      | V     | Min             | I <sub>OH</sub> = –24 mA (A <sub>n</sub> , B <sub>n</sub> )                                                                                          |
| V <sub>OL</sub>                    | Output LOW Voltage                      | 54ABT             | 0.55     |      | V     | Min             | I <sub>OL</sub> = 48 mA (A <sub>n</sub> , B <sub>n</sub> )                                                                                           |
| I <sub>IH</sub>                    | Input HIGH Current                      |                   | 5<br>5   |      | μA    | Max             | V <sub>IN</sub> = 2.7V ( $\overline{OE}$ , T/ $\overline{R}$ ) (Note 3)<br>V <sub>IN</sub> = V <sub>CC</sub> ( $\overline{OE}$ , T/ $\overline{R}$ ) |
| I <sub>BVI</sub>                   | Input HIGH Current Breakdown Test       |                   | 7        |      | μA    | Max             | V <sub>IN</sub> = 7.0V ( $\overline{OE}$ , T/ $\overline{R}$ )                                                                                       |
| I <sub>BVIT</sub>                  | Input HIGH Current Breakdown Test (I/O) |                   | 100      |      | μA    | Max             | V <sub>IN</sub> = 5.5V (A <sub>n</sub> , B <sub>n</sub> )                                                                                            |
| I <sub>IL</sub>                    | Input LOW Current                       |                   | –5<br>–5 |      | μA    | Max             | V <sub>IN</sub> = 0.5V ( $\overline{OE}$ , T/ $\overline{R}$ ) (Note 3)<br>V <sub>IN</sub> = 0.0V ( $\overline{OE}$ , T/ $\overline{R}$ )            |
| V <sub>ID</sub>                    | Input Leakage Test                      |                   | 4.75     |      | V     | 0.0             | I <sub>ID</sub> = 1.9 μA ( $\overline{OE}$ , T/ $\overline{R}$ )<br>All Other Pins Grounded                                                          |
| I <sub>IH</sub> + I <sub>OZH</sub> | Output Leakage Current                  |                   | 50       |      | μA    | 0 – 5.5V        | V <sub>OUT</sub> = 2.7V (A <sub>n</sub> , B <sub>n</sub> ); $\overline{OE}$ = 2.0V                                                                   |
| I <sub>IL</sub> + I <sub>OZL</sub> | Output Leakage Current                  |                   | –50      |      | μA    | 0 – 5.5V        | V <sub>OUT</sub> = 0.5V (A <sub>n</sub> , B <sub>n</sub> ); $\overline{OE}$ = 2.0V                                                                   |
| I <sub>OS</sub>                    | Output Short-Circuit Current            |                   | –100     | –275 | mA    | Max             | V <sub>OUT</sub> = 0.0V (A <sub>n</sub> , B <sub>n</sub> )                                                                                           |
| I <sub>CEX</sub>                   | Output High Leakage Current             |                   | 50       |      | μA    | Max             | V <sub>OUT</sub> = V <sub>CC</sub> (A <sub>n</sub> , B <sub>n</sub> )                                                                                |
| I <sub>ZZ</sub>                    | Bus Drainage Test                       |                   | 100      |      | μA    | 0.0             | V <sub>OUT</sub> = 5.5V (A <sub>n</sub> , B <sub>n</sub> );<br>All Others GND                                                                        |
| I <sub>CCH</sub>                   | Power Supply Current                    |                   | 50       |      | μA    | Max             | All Outputs HIGH                                                                                                                                     |
| I <sub>CCL</sub>                   | Power Supply Current                    |                   | 30       |      | mA    | Max             | All Outputs LOW                                                                                                                                      |
| I <sub>CCZ</sub>                   | Power Supply Current                    |                   | 50       |      | μA    | Max             | $\overline{OE}$ = V <sub>CC</sub> , T/ $\overline{R}$ = GND or V <sub>CC</sub> ;<br>All Other GND or V <sub>CC</sub>                                 |
| I <sub>CCT</sub>                   | Additional                              | Outputs Enabled   | 2.5      |      | mA    | Max             | V <sub>I</sub> = V <sub>CC</sub> – 2.1V                                                                                                              |
|                                    | I <sub>CC</sub> /Input                  | Outputs TRI-STATE | 2.5      |      | mA    |                 | $\overline{OE}$ , T/ $\overline{R}$ V <sub>I</sub> = V <sub>CC</sub> – 2.1V                                                                          |
|                                    |                                         | Outputs TRI-STATE | 50       |      | μA    |                 | Data Input V <sub>I</sub> = V <sub>CC</sub> – 2.1V<br>All Others at V <sub>CC</sub> or GND.                                                          |

## DC Electrical Characteristics (Continued)

| Symbol           | Parameter                                       | ABT245 |     |     | Units      | V <sub>CC</sub> | Conditions                                                                                                                                          |
|------------------|-------------------------------------------------|--------|-----|-----|------------|-----------------|-----------------------------------------------------------------------------------------------------------------------------------------------------|
|                  |                                                 | Min    | Typ | Max |            |                 |                                                                                                                                                     |
| I <sub>CCD</sub> | Dynamic I <sub>CC</sub> No Load<br><br>(Note 3) |        |     | 0.1 | mA/<br>MHz | Max             | Outputs Open<br><br>$\overline{OE} = \text{GND}$ , $T/\overline{R} = \text{GND}$ or V <sub>CC</sub><br>One Bit Toggling, 50% Duty Cycle<br>(Note 4) |

**Note 3:** Guaranteed but not tested.

**Note 4:** For 8 bits toggling, I<sub>CCD</sub> < 0.8 mA/MHz.

## DC Electrical Characteristics

| Symbol           | Parameter                                    | Min | Max   | Units | V <sub>CC</sub> | Conditions<br>C <sub>L</sub> = 50 pF,<br>R <sub>L</sub> = 500Ω |
|------------------|----------------------------------------------|-----|-------|-------|-----------------|----------------------------------------------------------------|
| V <sub>OLP</sub> | Quiet Output Maximum Dynamic V <sub>OL</sub> |     | 1.1   | V     | 5.0             | T <sub>A</sub> = 25°C (Note 5)                                 |
| V <sub>OLV</sub> | Quiet Output Minimum Dynamic V <sub>OL</sub> |     | -0.45 | V     | 5.0             | T <sub>A</sub> = 25°C (Note 5)                                 |

**Note 5:** Max number of outputs defined as (n). n – 1 data inputs are driven 0V to 3V. One output at LOW.

## AC Electrical Characteristics

| Symbol           | Parameter         | 54ABT                                                                                     |     | Units |
|------------------|-------------------|-------------------------------------------------------------------------------------------|-----|-------|
|                  |                   | T <sub>A</sub> = –55°C to +125°C<br>V <sub>CC</sub> = 4.5V–5.5V<br>C <sub>L</sub> = 50 pF |     |       |
|                  |                   | Min                                                                                       | Max |       |
| t <sub>PLH</sub> | Propagation Delay | 1.0                                                                                       | 4.8 | ns    |
| t <sub>PHL</sub> | Data to Outputs   | 1.0                                                                                       | 4.8 |       |
| t <sub>PZH</sub> | Output Enable     | 1.0                                                                                       | 6.7 | ns    |
| t <sub>PZL</sub> | Time              | 2.0                                                                                       | 7.5 |       |
| t <sub>PHZ</sub> | Output Disable    | 1.7                                                                                       | 7.4 | ns    |
| t <sub>PLZ</sub> | Time              | 1.7                                                                                       | 6.5 |       |

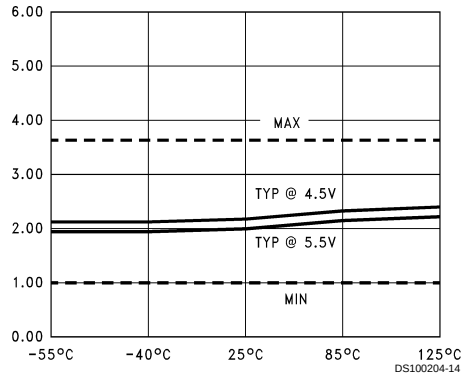
## Capacitance

| Symbol                    | Parameter         | Typ  | Units | Conditions<br>T <sub>A</sub> = 25°C                         |
|---------------------------|-------------------|------|-------|-------------------------------------------------------------|
| C <sub>IN</sub>           | Input Capacitance | 5.0  | pF    | V <sub>CC</sub> = 0V ( $\overline{OE}$ , $T/\overline{R}$ ) |
| C <sub>I/O</sub> (Note 6) | I/O Capacitance   | 11.0 | pF    | V <sub>CC</sub> = 5.0V (A <sub>n</sub> , B <sub>n</sub> )   |

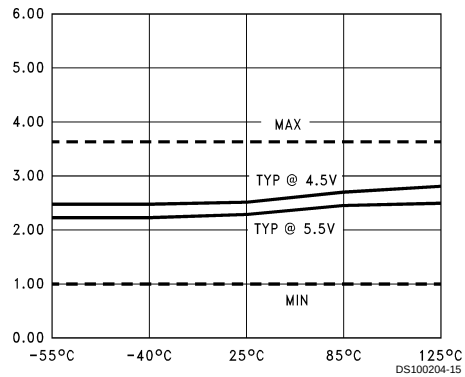
**Note 6:** C<sub>I/O</sub> is measured at frequency f = 1 MHz, per MIL-STD-883B, Method 3012.

## Capacitance (Continued)

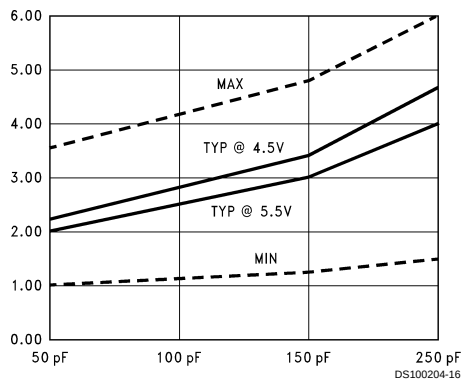
**$t_{PLH}$  vs Temperature ( $T_A$ )**  
 $C_L = 50$  pF, 1 Output Switching



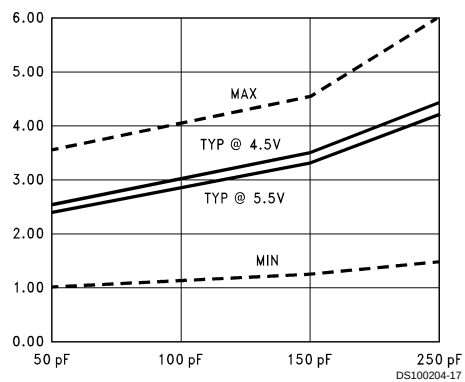
**$t_{PHL}$  vs Temperature ( $T_A$ )**  
 $C_L = 50$  pF, 1 Output Switching



**$t_{PLH}$  vs Load Capacitance**  
 1 Output Switching,  $T_A = 25^\circ\text{C}$

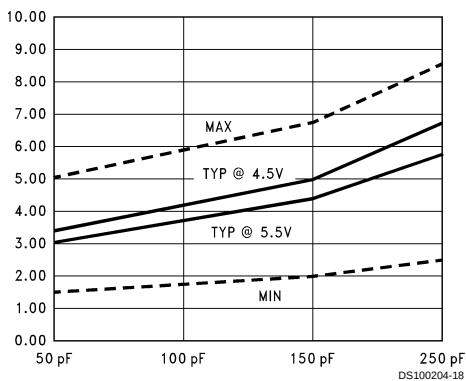


**$t_{PHL}$  vs Load Capacitance**  
 1 Output Switching,  $T_A = 25^\circ\text{C}$

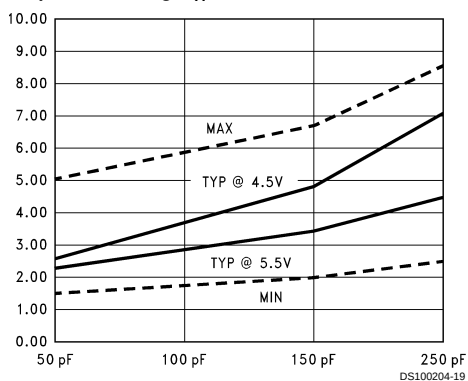


Dashed lines represent design characteristics; for specified guarantees, refer to AC Characteristics Table.

**$t_{PLH}$  vs Load Capacitance**  
 8 Outputs Switching,  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$

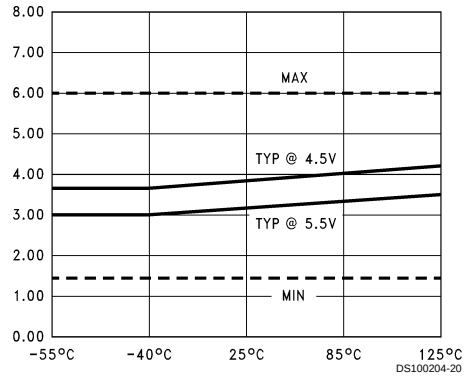


**$t_{PHL}$  vs Load Capacitance**  
 8 Outputs Switching,  $T_A = 25^\circ\text{C}$

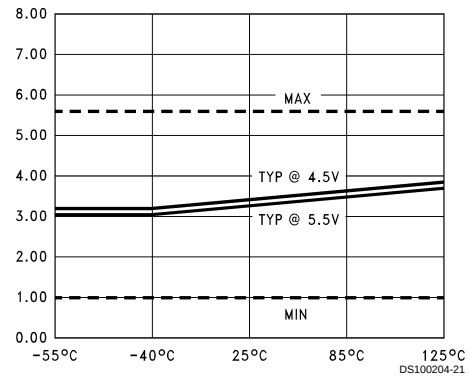


## Capacitance (Continued)

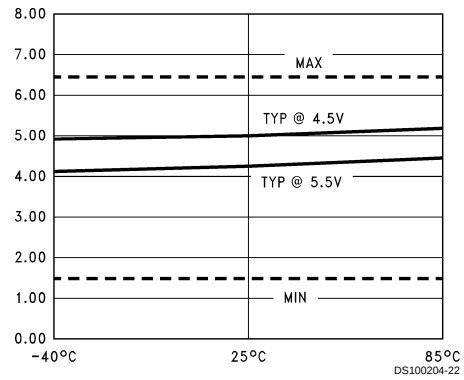
**$t_{PZL}$  vs Temperature ( $T_A$ )**  
 **$C_L = 50$  pF, 1 Output Switching**



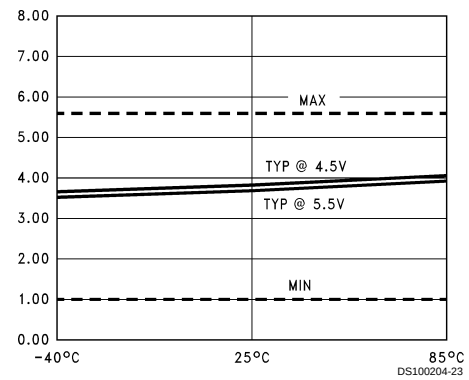
**$t_{PLZ}$  vs Temperature ( $T_A$ )**  
 **$C_L = 50$  pF, 1 Output Switching**



**$t_{PZL}$  vs Temperature ( $T_A$ )**  
 **$C_L = 50$  pF, 8 Outputs Switching**

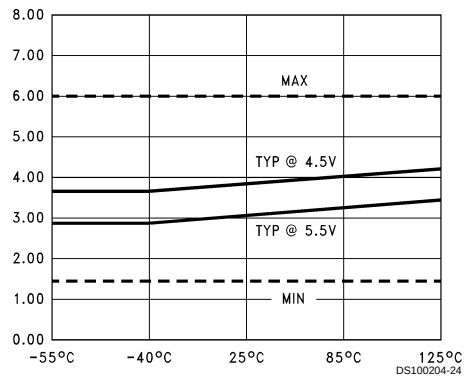


**$t_{PLZ}$  vs Temperature ( $T_A$ )**  
 **$C_L = 50$  pF, 8 Outputs Switching**

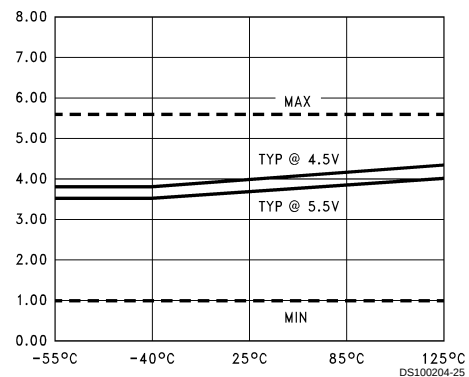


Dashed lines represent design characteristics; for specified guarantees, refer to AC Characteristics Table.

**$t_{PZH}$  vs Temperature ( $T_A$ )**  
 **$C_L = 50$  pF, 1 Output Switching**

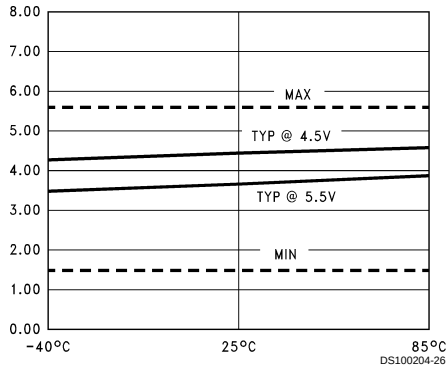


**$t_{PHZ}$  vs Temperature ( $T_A$ )**  
 **$C_L = 50$  pF, 1 Output Switching**

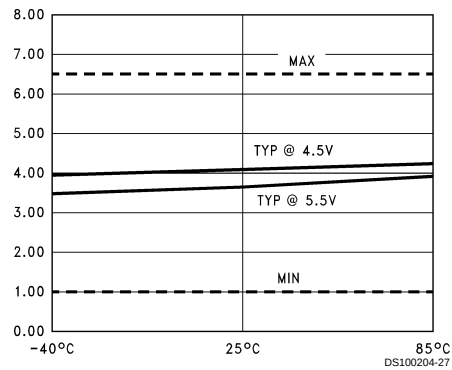


## Capacitance (Continued)

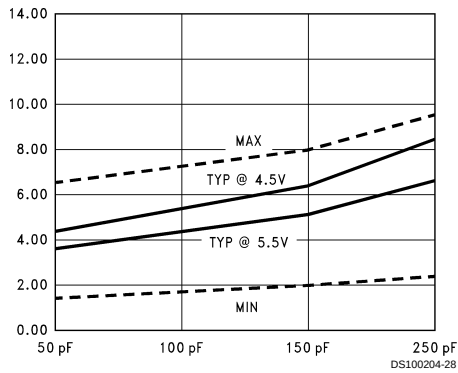
**$t_{PZH}$  vs Temperature ( $T_A$ )**  
 $C_L = 50$  pF, 8 Outputs Switching



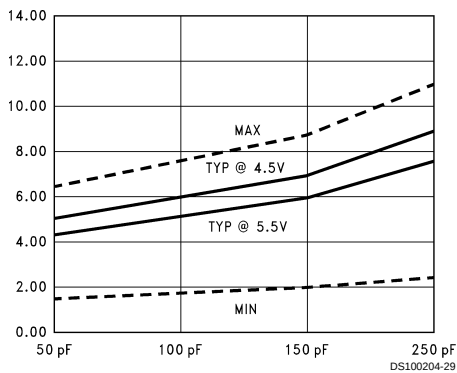
**$t_{PHZ}$  vs Temperature ( $T_A$ )**  
 $C_L = 50$  pF, 8 Outputs Switching



**$t_{PZH}$  vs Load Capacitance**  
 8 Outputs Switching,  $T_A = 25^\circ\text{C}$

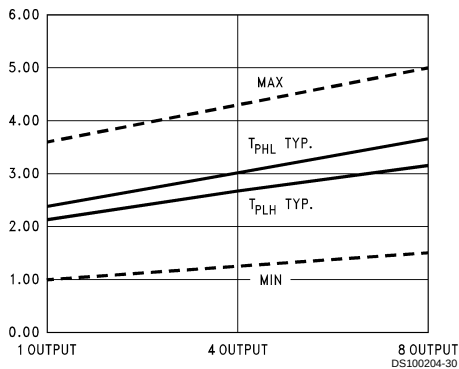


**$t_{PZL}$  vs Load Capacitance**  
 8 Outputs Switching,  $T_A = 25^\circ\text{C}$

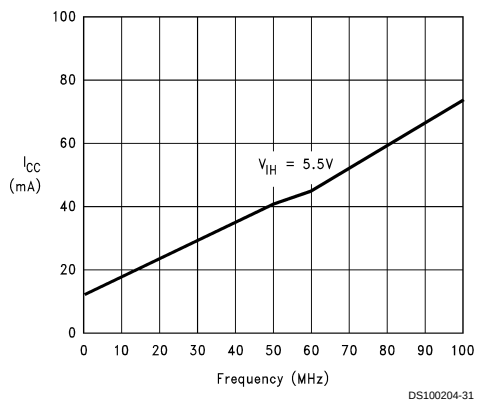


Dashed lines represent design characteristics; for specified guarantees, refer to AC Characteristics Table.

**$t_{PLH}$  and  $t_{PHL}$  vs Number Outputs Switching**  
 $V_{CC} = 5.0\text{V}$ ,  $T_A = 25^\circ\text{C}$ ,  $C_L = 50$  pF

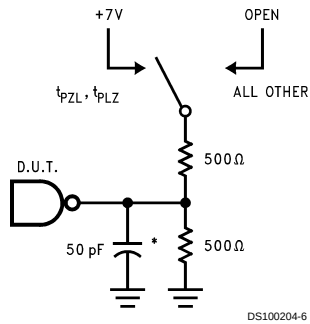


**$I_{CC}$  vs Frequency, Average,  $T_A = 25^\circ\text{C}$ ,  
 All Outputs Unloaded/Unterminated**



Dashed lines represent design characteristics; for specified guarantees, refer to AC Characteristics Table.

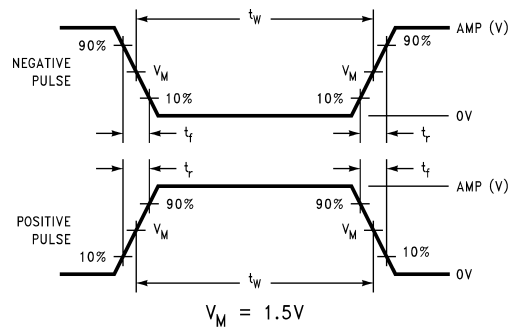
## AC Loading



DS100204-6

\*Includes jig and probe capacitance

FIGURE 1. Standard AC Test Load



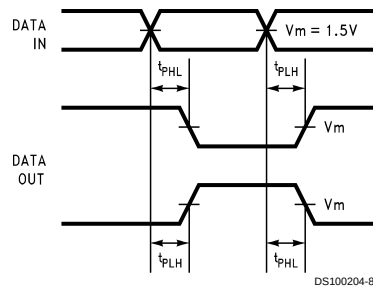
DS100204-7

FIGURE 2. Test Input Signal Levels

| Amplitude | Rep. Rate | $t_w$  | $t_r$  | $t_f$  |
|-----------|-----------|--------|--------|--------|
| 3.0V      | 1 MHz     | 500 ns | 2.5 ns | 2.5 ns |

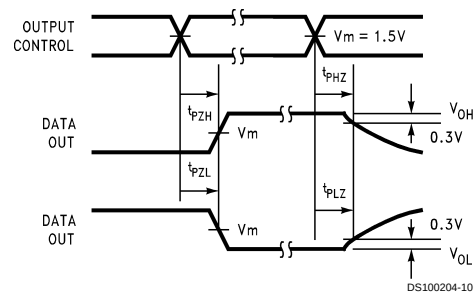
FIGURE 3. Test Input Signal Requirements

## AC Waveforms



DS100204-8

FIGURE 4. Propagation Delay Waveforms for Inverting and Non-Inverting Functions

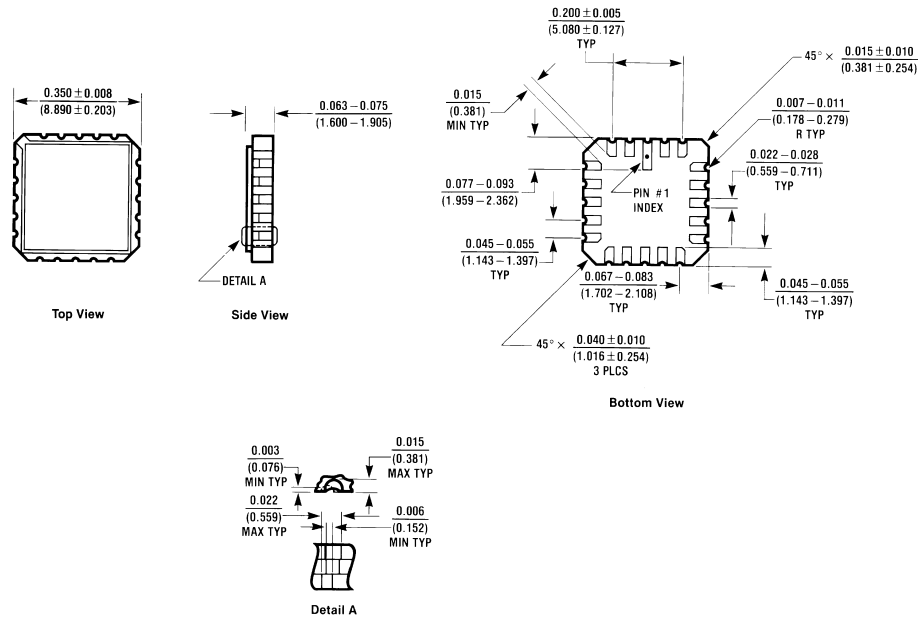


DS100204-10

FIGURE 5. TRI-STATE Output HIGH and LOW Enable and Disable Times

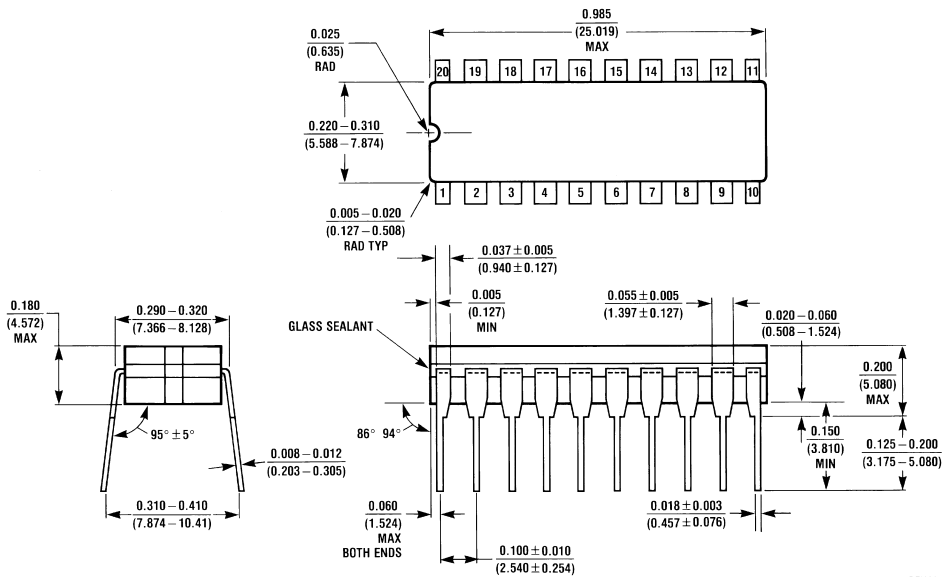


## Physical Dimensions inches (millimeters) unless otherwise noted



E20A (REV D)

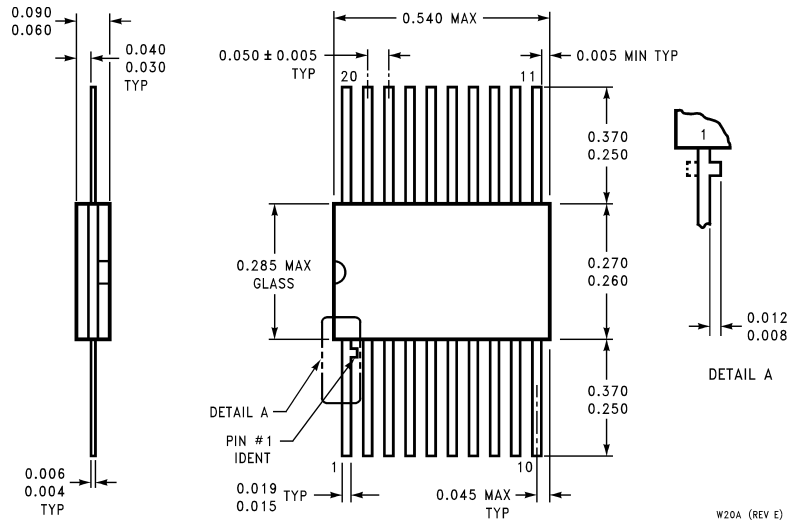
**20-Terminal Ceramic Chip Carrier (L)**  
**NS Package Number E20A**



J20A (REV M)

**20-Lead Ceramic Dual-In-Line Package (D)**  
**NS Package Number J20A**

# Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**20-Lead Ceramic Flatpak (F)**  
**NS Package Number W20A**

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**National Semiconductor Corporation**  
Americas  
Tel: 1-800-272-9959  
Fax: 1-800-737-7018  
Email: support@nsc.com

www.national.com

**National Semiconductor Europe**

Fax: +49 (0) 1 80-530 85 86  
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Связь**

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Благодаря сотрудничеству с мировыми поставщиками мы осуществляем комплексные и плановые поставки широчайшего спектра электронных компонентов.

Собственная эффективная логистика и склад в обеспечивает надежную поставку продукции в точно указанные сроки по всей России.

Мы осуществляем техническую поддержку нашим клиентам и предпродажную проверку качества продукции. На все поставляемые продукты мы предоставляем гарантию .

Осуществляем поставки продукции под контролем ВП МО РФ на предприятия военно-промышленного комплекса России , а также работаем в рамках 275 ФЗ с открытием отдельных счетов в уполномоченном банке. Система менеджмента качества компании соответствует требованиям ГОСТ ISO 9001.

Минимальные сроки поставки, гибкие цены, неограниченный ассортимент и индивидуальный подход к клиентам являются основой для выстраивания долгосрочного и эффективного сотрудничества с предприятиями радиоэлектронной промышленности, предприятиями ВПК и научно-исследовательскими институтами России.

С нами вы становитесь еще успешнее!

**Наши контакты:**

**Телефон:** +7 812 627 14 35

**Электронная почта:** [sales@st-electron.ru](mailto:sales@st-electron.ru)

**Адрес:** 198099, Санкт-Петербург,  
Промышленная ул, дом № 19, литера Н,  
помещение 100-Н Офис 331